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APPLICATION NO. FILING DATE FIRST NAMED INVENTOR ATTORNEY DOCKET NO. CONFIRMATION NO. Hidetoshi Ohnuma 10/603,689 06/26/2003 2872 SON-2769 **EXAMINER** 23353 02/13/2006 7590 RADER FISHMAN & GRAUER PLLC CHACKO DAVIS, DABORAH LION BUILDING ART UNIT PAPER NUMBER 1233 20TH STREET N.W., SUITE 501

1756
DATE MAILED: 02/13/2006

Please find below and/or attached an Office communication concerning this application or proceeding.

			$l \mathcal{N}$
	Application No.	Applicant(s)	
Office Action Summary	10/603,689	OHNUMA, HIDETOSHI	
	Examiner	Art Unit	
	Daborah Chacko-Davis	1756	
The MAILING DATE of this communication a Period for Reply	appears on the cover sheet with	the correspondence address	
A SHORTENED STATUTORY PERIOD FOR REF WHICHEVER IS LONGER, FROM THE MAILING  - Extensions of time may be available under the provisions of 37 CFR after SIX (6) MONTHS from the mailing date of this communication.  - If NO period for reply is specified above, the maximum statutory perions are reply within the set or extended period for reply will, by state that the material patent term adjustment. See 37 CFR 1.704(b).	DATE OF THIS COMMUNICA 1.136(a). In no event, however, may a repl od will apply and will expire SIX (6) MONTH tute, cause the application to become ABAN	TION.  be timely filed  from the mailing date of this communication.  DONED (35 U.S.C. § 133).	
Status			
1) Responsive to communication(s) filed on <u>03</u>	<u>June 2005</u> .		
·	his action is non-final.		
3) Since this application is in condition for allow	·	•	
closed in accordance with the practice unde	er Ex parte Quayle, 1935 C.D. 1	1, 453 O.G. 213.	
Disposition of Claims			
<ul> <li>4) ☐ Claim(s) 1-7 and 15-20 is/are pending in the 4a) Of the above claim(s) is/are withd</li> <li>5) ☐ Claim(s) is/are allowed.</li> <li>6) ☐ Claim(s) 1-7 and 15-20 is/are rejected.</li> <li>7) ☐ Claim(s) is/are objected to.</li> <li>8) ☐ Claim(s) are subject to restriction and</li> </ul>	rawn from consideration.		
Application Papers			
9) The specification is objected to by the Exami 10) The drawing(s) filed on is/are: a) a Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the	ccepted or b) objected to by he drawing(s) be held in abeyance ection is required if the drawing(s)	. See 37 CFR 1.85(a). is objected to. See 37 CFR 1.121(d).	
Priority under 35 U.S.C. § 119			
12) ☐ Acknowledgment is made of a claim for foreign a) ☐ All b) ☐ Some * c) ☐ None of:      1. ☐ Certified copies of the priority docume 2. ☐ Certified copies of the priority docume 3. ☐ Copies of the certified copies of the priority docume application from the International Bure * See the attached detailed Office action for a life.	ents have been received. ents have been received in Appriority documents have been re eau (PCT Rule 17.2(a)).	lication No ceived in this National Stage	
Attachment(s)	🗖 .		
Notice of References Cited (PTO-892)     Notice of Draftsperson's Patent Drawing Review (PTO-948)	4)	mary (PTO-413) fail Date	
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/0 Paper No(s)/Mail Date		mal Patent Application (PTO-152)	

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## **DETAILED ACTION**

## Election/Restrictions

1. Applicant's election of Group I, claims 1-7, and 15-20, in the reply filed on August 3, 2005, is acknowledged. Because applicant did not distinctly and specifically point out the supposed errors in the restriction requirement, the election has been treated as an election without traverse (MPEP § 818.03(a)). The non-elected invention, Group II, claims 8-14, was cancelled in the reply filed on August 3, 2005.

# Claim Rejections - 35 USC § 102

2. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (e) the invention was described in (1) an application for patent, published under section 122(b), by another filed in the United States before the invention by the applicant for patent or (2) a patent granted on an application for patent by another filed in the United States before the invention by the applicant for patent, except that an international application filed under the treaty defined in section 351(a) shall have the effects for purposes of this subsection of an application filed in the United States only if the international application designated the United States and was published under Article 21(2) of such treaty in the English language.
- 3. Claims 1-7, 15-20, are rejected under 35 U.S.C. 102(e) as being anticipated by U.S. Patent Application Publication No. 2003/0138742 (Irie et al., herein after referred to as Irie).

Irie, in the abstract, in [0013], [0015], [0022], [0041], [0095], [0132], [0134], [0135], [0136], [0137], [0145], [0146], [0162], [0163], [0175], [0201], [0202], [0203], [0204], and in figures 2B, 4, and 6, discloses a method of projecting a desired pattern (photolithography) on a device substrate (object to be exposed) using a reflective mask

(reticle for use in the EUV exposure region) comprising providing reticles (master reticles R1....RN) each having pattern elements (mark elements) with mark elements aligned in the X-direction (125X, mark elements horizontal to the projection vector), and mark elements aligned in the Y-direction (125Y, mark elements perpendicular to the projection vector), wherein the reticle is rotated by rotational means (main control system) so as to align the corresponding mark elements (either mark element in the Xdirection or mark element in the Y-direction) in the Z-direction (projection vector, best focus position), and performing sequential exposures (X-direction elements rotated about 90 degree to align in the projection beam, and Y-direction elements rotated about 90 degree to align with the projection beam, performing plural exposures) through the respective reticles, while adjusting the tilt angles by rotating the substrate and the reticles (125X, and 125Y) through the main control system thereby canceling any errors (due to angle deviations) and forming the desired pattern on the substrate (reference 4) (claims 1-2, 6-7, 15-16, and 20). Irie, in [0200], [0204], discloses that the exposure light is either a EUV ray or an X-ray (claims 3, and 17). Irie, in [0133], discloses that the patterns can be formed on the substrate using an electron beam system (electron beam exposure performed) (claims 3, and 18). Irie, in [0029], [0109], [0119], and [0134], and in figures 2B, and 4, discloses that the reticle pattern that includes the mark elements formed in the Y-direction (125Y, V-line mask) relative to the projection vector (best focus position) corresponds to the scanning direction (operating direction) of the optical system (exposure system) (claims 5, and 19).

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## Conclusion

4. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Daborah Chacko-Davis whose telephone number is (571) 272-1380. The examiner can normally be reached on M-F 9:30 - 6:00. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Mark F Huff can be reached on (571) 272-1385. The fax phone number for the organization where this application or proceeding is assigned is (571) 273-8300. Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

aca Mb

February 7, 2006.

JOHN A. MCPHERSON PRIMARY EXAMINER

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